Application/Control No. Applicant(s)/Patent Under Reexamination 10/060,483 CHEN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Vikki H Trinh 2814 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,426,281 07-2002 Lin et al. 438/612 Α US-6,426,556 07-2002 В Lin, Mou-Shiung 257/738 US-6,452,270 09-2002 Huang, Min-Lung Ç 257/738 US-D US-Ε US-F US-G US-Н US-US-US-K US-L US-M FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) υ ٧ W

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